

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Substitute for form 1449/PTO)				ATTY. DOCKET NO. <b>071971-0724</b>		SERIAL NO. <b>10/591,597</b>	
				APPLICANT <b>Tohru YAMAOKA, et al.</b>			
				FILING DATE <b>September 05, 2006</b>		GROUP <b>2615</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US 4,441,038	04-03-1984	TANAKA et al.			
		US 2002/0081846 A1	06-27-2002	HARUHANA et al.	Corresponds to JP 57-14296		
		US 2003/0026443 A1	02-06-2003	YASUNO et al.	Corresponds to JP 2002-198370		
		US 2002/0180047 A1	12-05-2002	HARUHANA et al.			
		US 2003/0015798 A1	01-23-2003	HARUHANA et al.			
		US 2007/0217635 A1	09-20-2007	OGURA et al.			
		US 6,731,766 B2	05-04-2004	YASUNO et al.			
		US 6,859,542 B2	02-22-2005	JOHANNSEN et al.			
		US 6,479,878 B1	11-12-2002	OKAWA et al.	Corresponds to JP 11-331988		
		US 6,847,090 B2	01-25-2005	LOEPPERT			
		US 5,490,220	02-06-1996	LOEPPERT			
		US 2003/0007655 A1	01-09-2003	YUN et al.	Corresponds to JP 2004-510373		
		US 5,677,965	10-14-1997	MORET et al.	Corresponds to JP 06-217397		
		US 6,586,163 B1	07-01-2003	OKABE et al.	Corresponds to JP 2001-51424		
		6,383,832 B1	05-07-2002	NAKABAYASHI	Corresponds to JP 2002-315097		
		2001/0033670 A1	10-25-2001	TAI et al.			
		2004/0114775 A1	06-17-2004	CHANG			
		2004/0259286 A1	12-23-2004	DEHE et al.			
		2005/0254673 A1	11-17-2005	HSIEH et al.			
		7,039,202 B1	05-02-2006	TAKEUCHI			
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number 4-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No	
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
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		US					
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		JP 2002-033241	01-31-2002	MINAMI UCHITSUGU HOSIDEN CORP			JAPAN (w/ English abstract)
		JP 2002-320294	10-31-2002	MITSUBISHI ELECTRIC CORP			JAPAN (w/ English abstract)
		JP 2002-335599	11-22-2002	SHARP CORP			JAPAN (w/ English abstract)
		JP 2003-031820	01-31-2003	NIPPON HOSO KYOKAI <NHK>			JAPAN (w/ English abstract)
		JP 2003-223499	08-08-2003	NEXTWARE LTD URAKUBO KEIJI SAKAMAKI YOSHIMASA			JAPAN (w/ English abstract)
		JP 2004-166262	06-10-2004	MATSUSHITA ELECTRIC IND CO LTD			JAPAN (w/ English abstract)
		WO 02/37893 A1	05-10-2002	BSE CO., LTD.			X
		WO 99/65277	12-16-1999	MICROTRONIC A/S			X
		JP 57-14296				Corresponds to US 2002/0081846 A1	
		JP 2002-198370				Corresponds to US 2003/0026443 A1	
		JP 11-331988				Corresponds to US 6,479,878 B1	
		JP 2004-510373				Corresponds to US 2003/0007655 A1	
		JP 06-217397				Corresponds to US 5,677,965	
		JP 2001-51424				Corresponds to US 6,586,163 B1	
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